

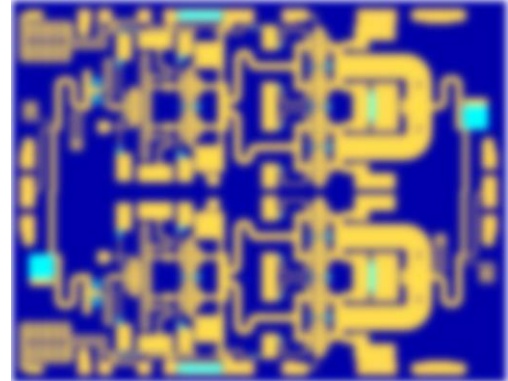
### Product Overview

Qorvo’s TGA2222 is a wide band power amplifier MMIC fabricated on Qorvo’s production 0.15  $\mu\text{m}$  GaN on SiC process (QGaN15). Covering 32–38 GHz, the TGA2222 provides 40 dBm (10 W) of saturated output power and 16 dB of large-signal gain while achieving > 22% power-added efficiency.

The TGA2222 employs a balanced architecture to minimize performance sensitivity to load variation. Its RF ports are DC coupled to ground for optimum ESD performance. The TGA2222 has DC blocking capacitors on both RF ports, which are matched to 50 ohms.

The TGA2222 can support a wide range of operating conditions, including CW operation, making it well-suited for both commercial and military systems.

Lead-free and RoHS compliant.

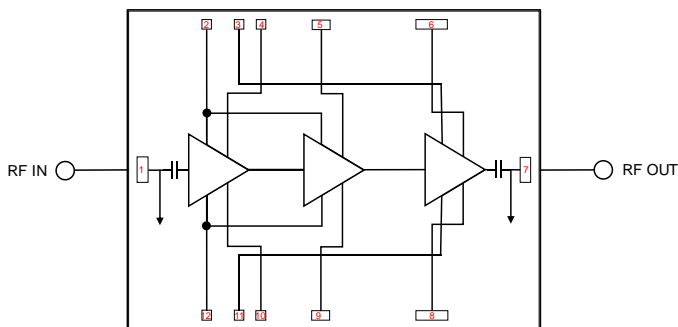


### Key Features

- Frequency Range: 32 – 38 GHz
- $P_{SAT}$  ( $P_{IN}=24$  dBm): > 40 dBm
- PAE ( $P_{IN}=24$  dBm): > 22 %
- Power Gain ( $P_{IN}=24$  dBm): > 16 dB
- Small Signal Gain: > 25 dB
- Bias (pulsed):  $V_D = 26$  V,  $I_{DQ} = 640$  mA
- Bias (CW):  $V_D = 24$  V,  $I_{DQ} = 640$  mA
- Die Dimensions: 3.43 x 2.65 x 0.05 mm

*Performance is typical across frequency. Please reference electrical specification table and data plots for more details.*

### Functional Block Diagram



### Applications

- Communications
- Radar
- Satcom
- EW
- Space communications
- Point to point communications

### Ordering Information

Part No.	Description
TGA2222	32 – 38 GHz 10 W GaN Amplifier (10 Pcs.)
TGA2222DS2	Samples (2 pcs.)
TGA2222EVB1	Evaluation Board for TGA2222

## Absolute Maximum Ratings

Parameter	Value / Range
Drain Voltage ( $V_D$ )	29.5 V
Gate Voltage Range ( $V_G$ )	-4 V to 0 V
Drain Current ( $I_{D1}/I_{D2}/I_{D3}$ ) (T=85 °C)	1.06 / 1.70 / 3.44 A
Gate Current ( $I_G$ )	See plot pg. 15
Power Dissipation ( $P_{DISS}$ ), 85 °C	60 W
Input Power ( $P_{IN}$ ), 50 $\Omega$ , CW, $V_D=24$ V, $I_{DQ}=640$ mA, 85 °C	30 dBm
Input Power ( $P_{IN}$ ), 3:1 VSWR, CW, $V_D=26$ V, $I_{DQ}=640$ mA, 85 °C	30 dBm
Soldering Temperature (30 seconds, maximum)	320 °C
Storage Temperature	-55 to +125 °C

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

## Recommended Operating Conditions

Parameter	Value / Range
Drain Voltage ( $V_D$ , Pulsed)	26 V
Drain Voltage ( $V_D$ , CW)	24 V
Drain Current ( $I_{DQ}$ )	640 mA
Operating Temperature	-40 to +85 °C

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

### Electrical Specifications (Pulsed)

Parameter		Min	Typ	Max	Units
Operational Frequency		32		38	GHz
Output Power ( $P_{IN} = 24$ dBm) (Pulsed, $V_D = 26$ V)	32 GHz		40.2		dBm
	35 GHz		41.1		dBm
	38 GHz		40.8		dBm
Power Added Efficiency ( $P_{IN} = 24$ dBm) (Pulsed, $V_D = 26$ V)	32 GHz		17.7		%
	35 GHz		19.3		%
	38 GHz		20.3		%
Small Signal Gain (CW, $V_D = 26$ V)	32 GHz		28.3		dB
	35 GHz		24.4		dB
	38 GHz		21.6		dB
Input Return Loss (CW, $V_D = 26$ V)	32 GHz		21		dB
	35 GHz		23		dB
	38 GHz		17		dB
Output Return Loss (CW, $V_D = 26$ V)	32 GHz		16		dB
	35 GHz		38		dB
	38 GHz		18		dB
Output Power Temp. Coeff. (85 °C to 25 °C, $V_D = 26$ V (pulsed), $P_{IN} = 24$ dBm)			-0.010		dB/°C
Sm. Sig. Gain Temp. Coefficient (85 °C to -40 °C, CW, $V_D = 26$ V)			-0.086		dB/°C

Test conditions, unless otherwise noted: T = 25 °C,  $V_D = 26$  V,  $I_{DQ} = 640$  mA, PW = 100 us, Duty Cycle = 10%

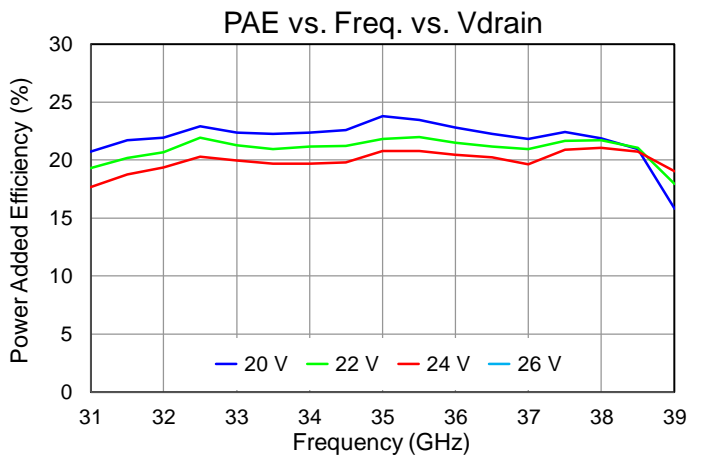
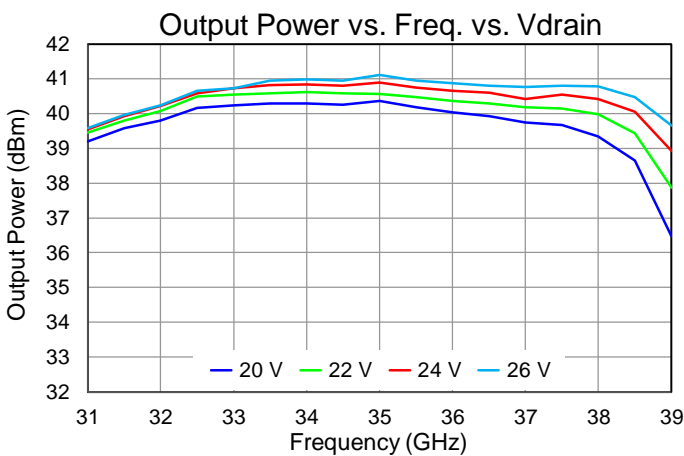
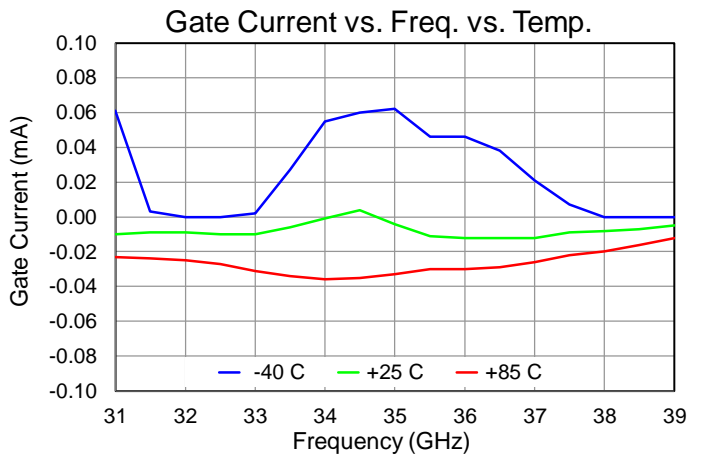
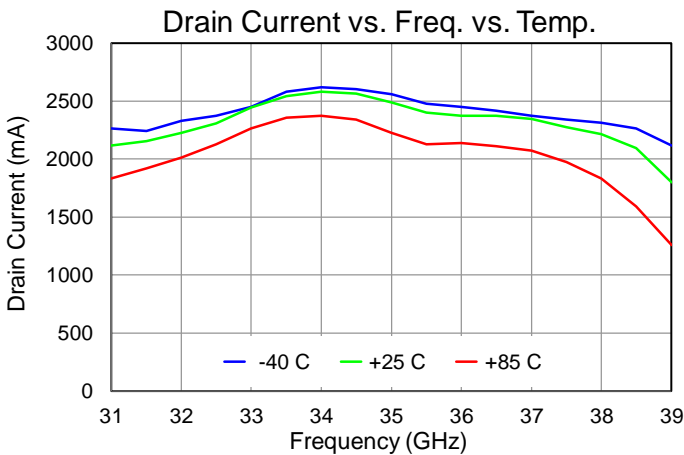
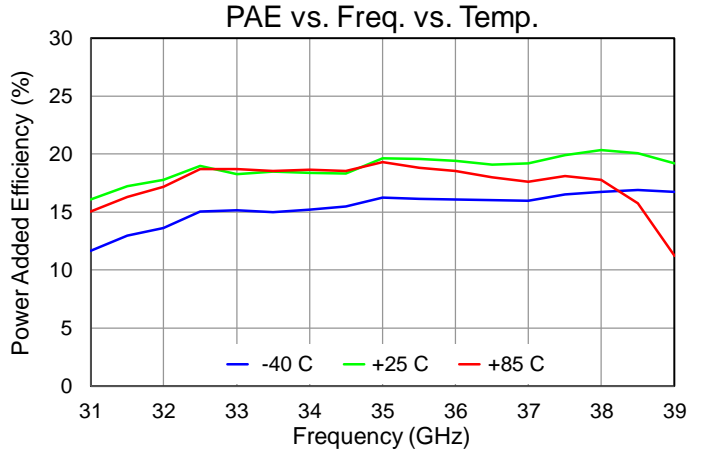
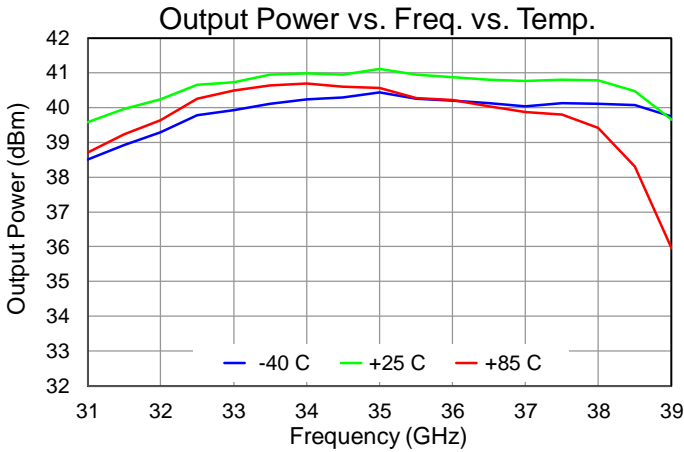
### Electrical Specifications (CW)

Parameter		Min	Typ	Max	Units
Operational Frequency		32		38	GHz
Output Power ( $P_{IN} = 24$ dBm) (CW, $V_D = 24$ V)	32 GHz		40.4		dBm
	35 GHz		41.0		dBm
	38 GHz		40.2		dBm
Power Added Efficiency ( $P_{IN} = 24$ dBm) (CW, $V_D = 24$ V)	32 GHz		22.3		%
	35 GHz		23.2		%
	38 GHz		22.6		%
Small Signal Gain ( $V_D = 24$ V)	32 GHz		29.5		dB
	35 GHz		25.6		dB
	38 GHz		22.1		dB
Input Return Loss ( $V_D = 24$ V)	32 GHz		21		dB
	35 GHz		32		dB
	38 GHz		16		dB
Output Return Loss ( $V_D = 24$ V)	32 GHz		16		dB
	35 GHz		30		dB
	38 GHz		18		dB
Output Power Temp. Coeff. (85 °C to 25 °C, $V_D = 24$ V (CW), $P_{IN} = 24$ dBm)			-0.030		dB/°C
Sm. Sig. Gain Temp. Coefficient (85 °C to -40 °C, $V_D = 24$ V)			-0.086		dB/°C

Test conditions, unless otherwise noted: T = 25 °C,  $V_D = 24$  V,  $I_{DQ} = 640$  mA

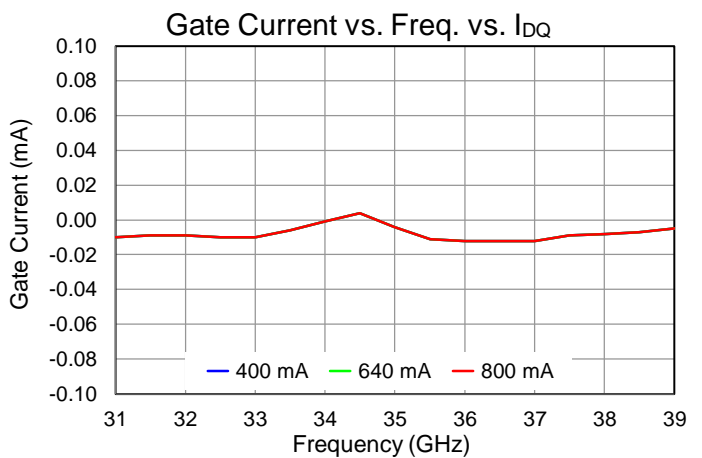
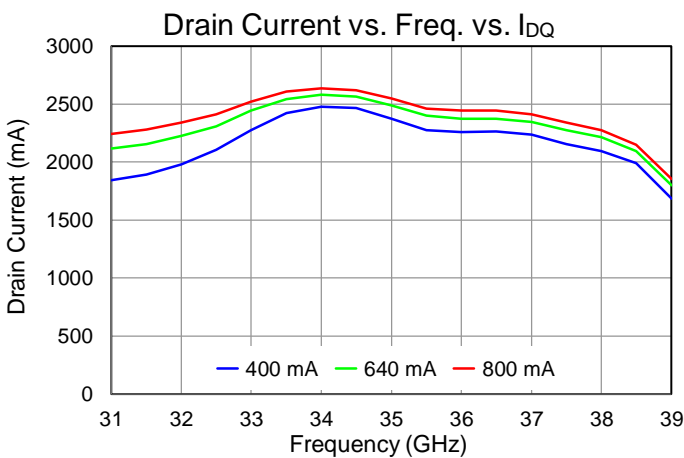
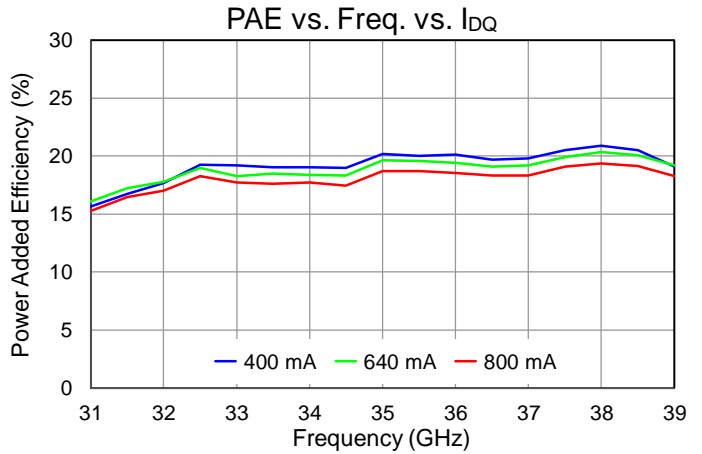
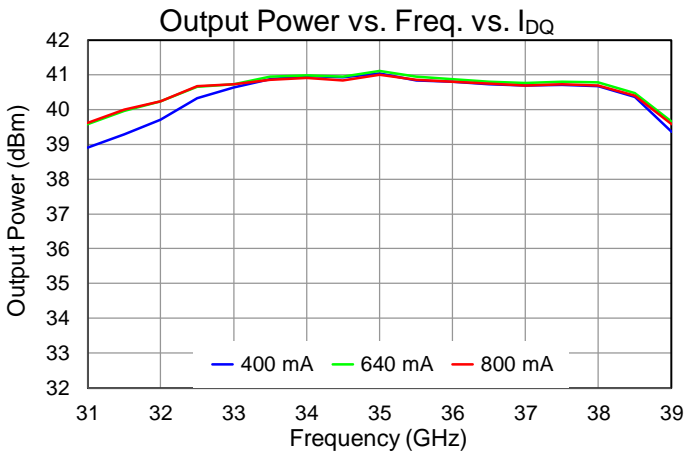
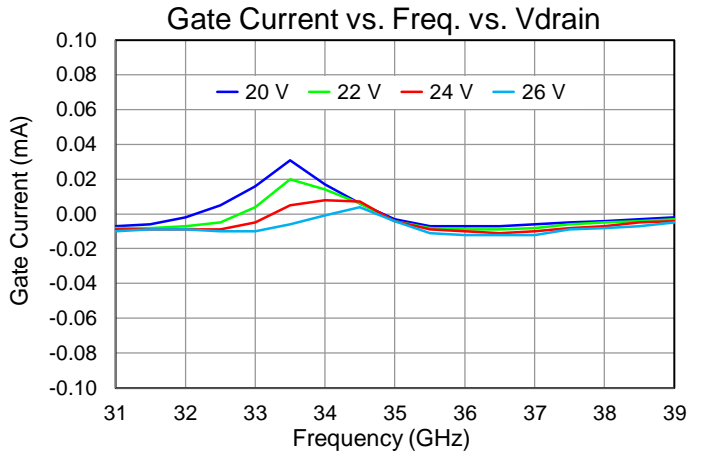
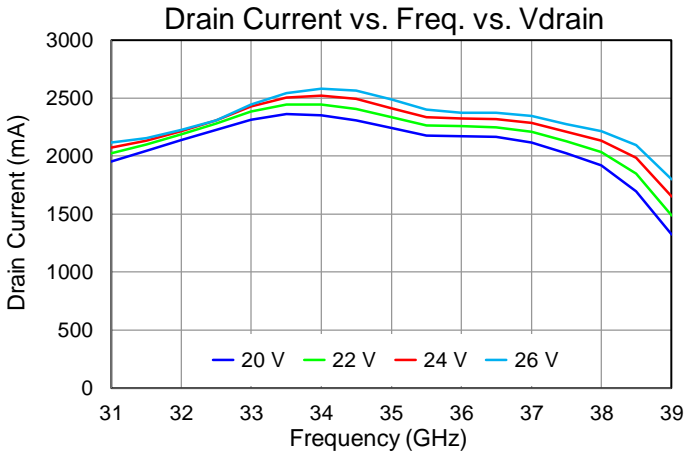
## Performance Plots – Large Signal (Pulsed)

Test conditions, unless otherwise noted:  $V_D=26$  V,  $I_{DQ}=640$  mA,  $T=+25$  °C,  $P_{IN}=24$  dBm,  $PW=100$  us, Duty Cycle=10%



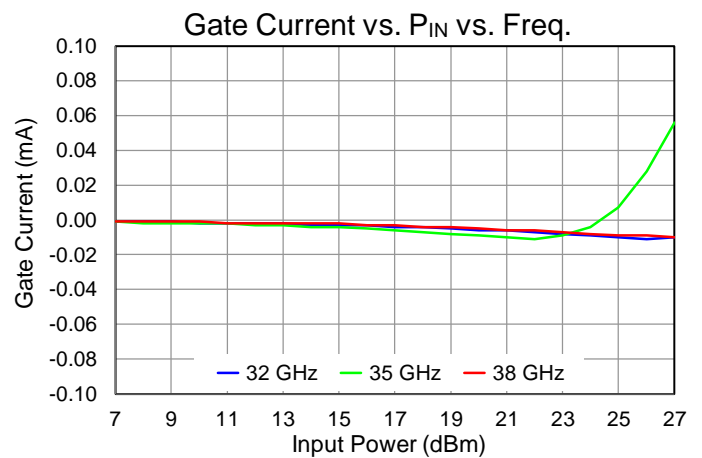
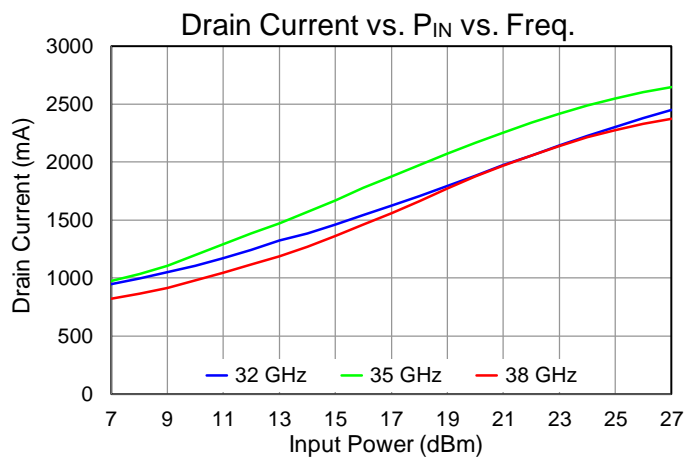
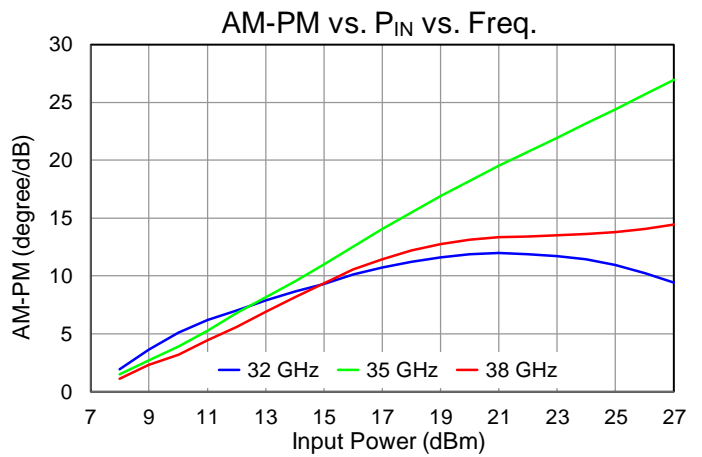
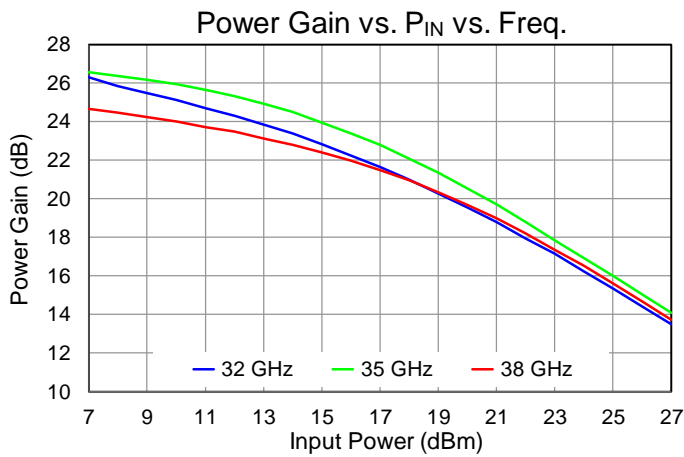
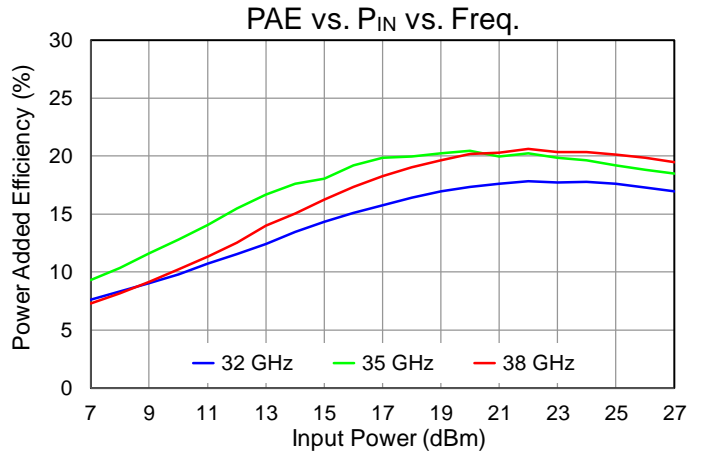
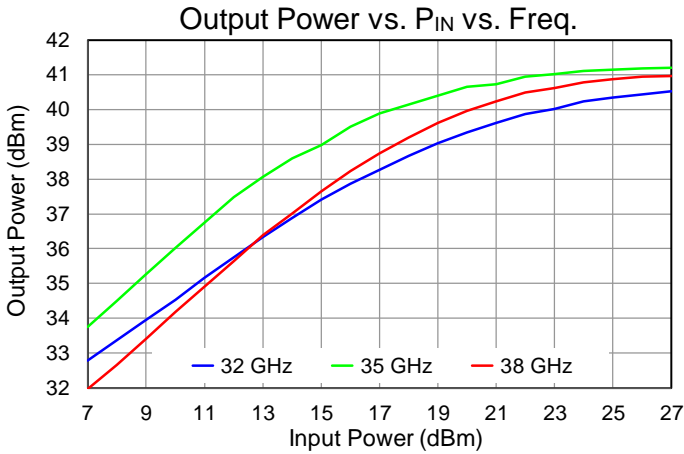
## Performance Plots – Large Signal (Pulsed)

Test conditions, unless otherwise noted:  $V_D=26\text{ V}$ ,  $I_{DQ}=640\text{ mA}$ ,  $T=+25\text{ }^\circ\text{C}$ ,  $P_{IN}=24\text{ dBm}$ ,  $PW=100\text{ }\mu\text{s}$ , Duty Cycle=10%



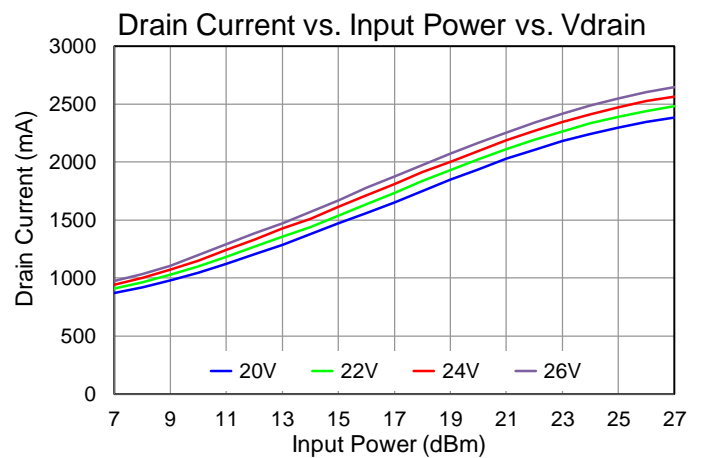
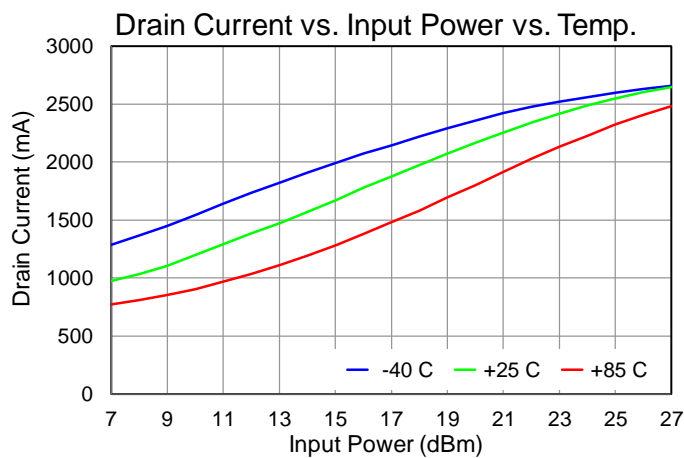
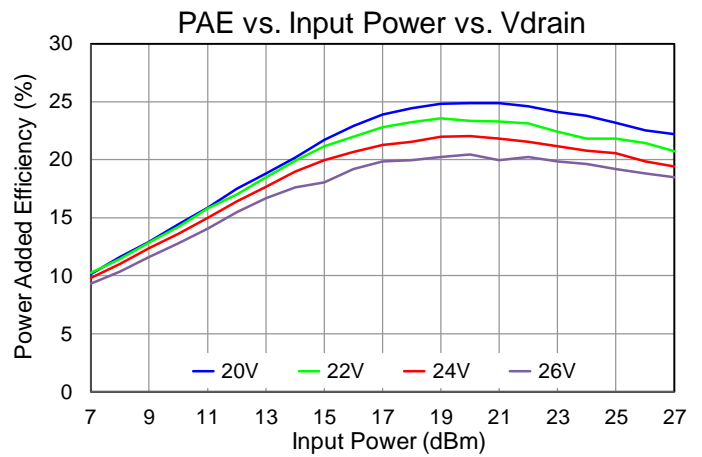
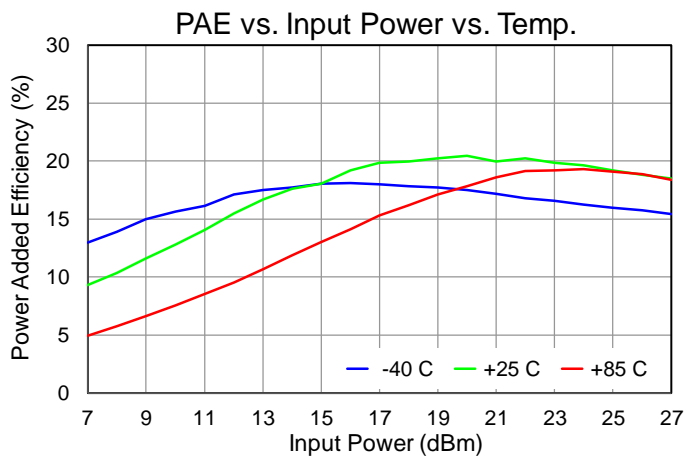
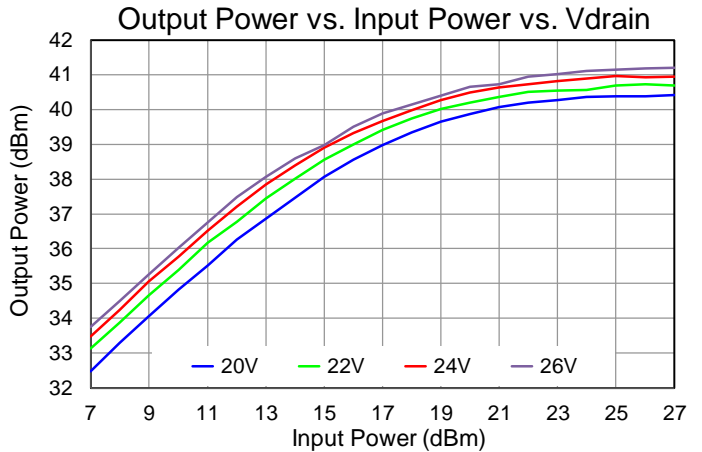
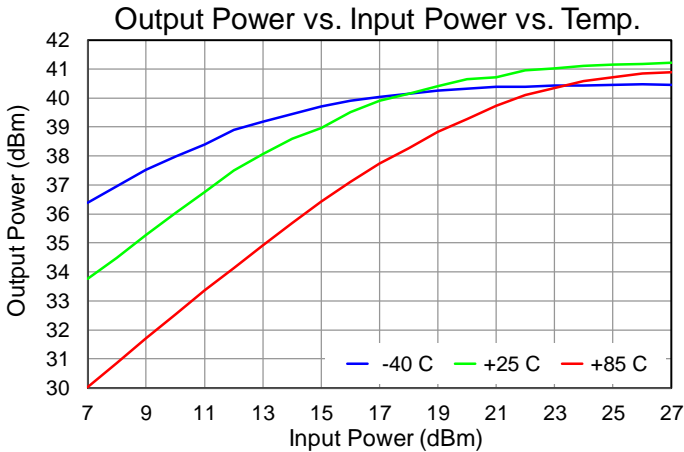
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Test conditions, unless otherwise noted:  $V_D=26\text{ V}$ ,  $I_{DQ}=640\text{ mA}$ ,  $T=+25\text{ }^\circ\text{C}$ ,  $PW=100\text{ }\mu\text{s}$ , Duty Cycle=10%



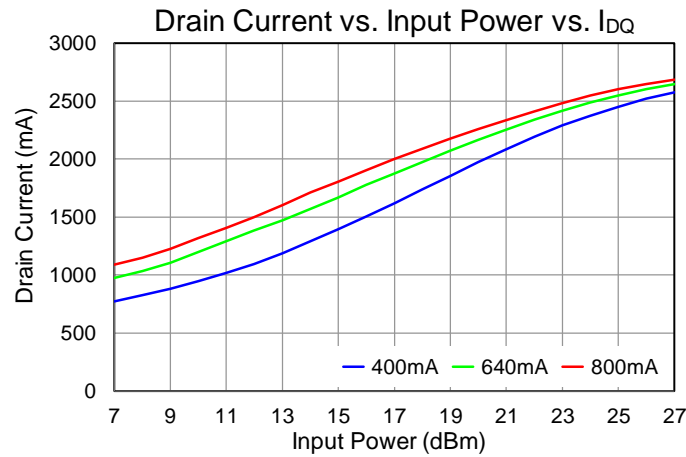
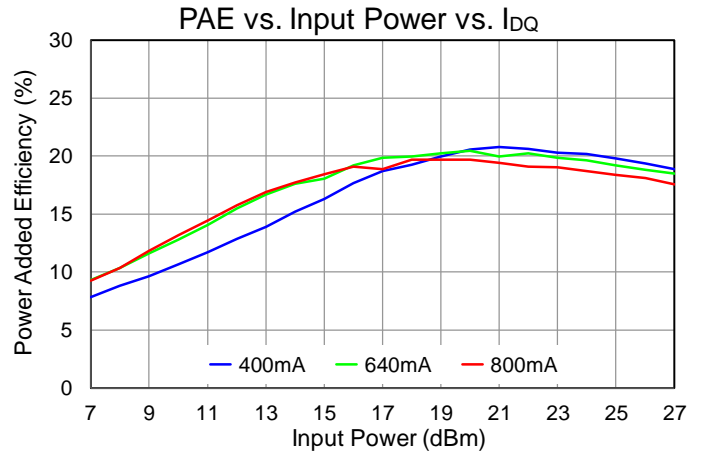
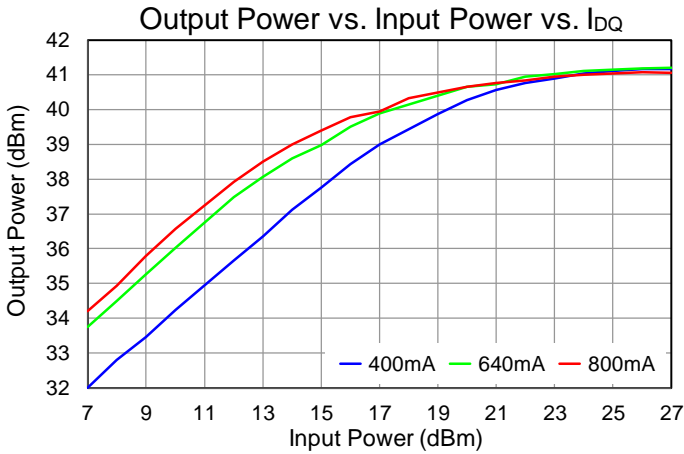
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Test conditions, unless otherwise noted:  $V_D=26\text{ V}$ ,  $I_{DQ}=640\text{ mA}$ ,  $T=+25\text{ }^\circ\text{C}$ ,  $PW=100\text{ }\mu\text{s}$ , Duty Cycle=10%, Freq.=35 GHz



Performance Plots – Large Signal (Pulsed)

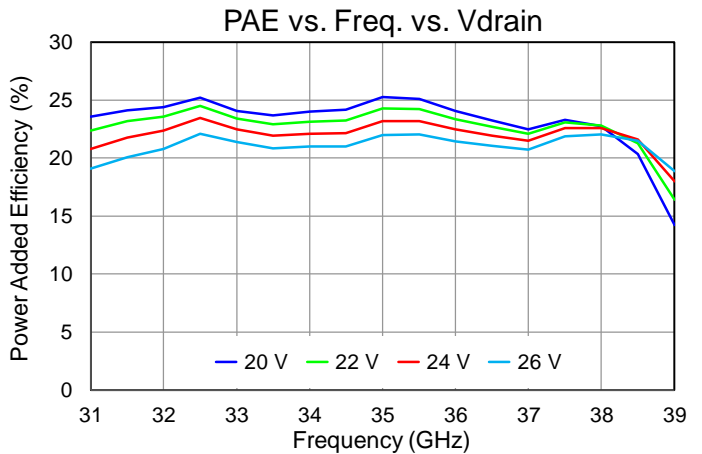
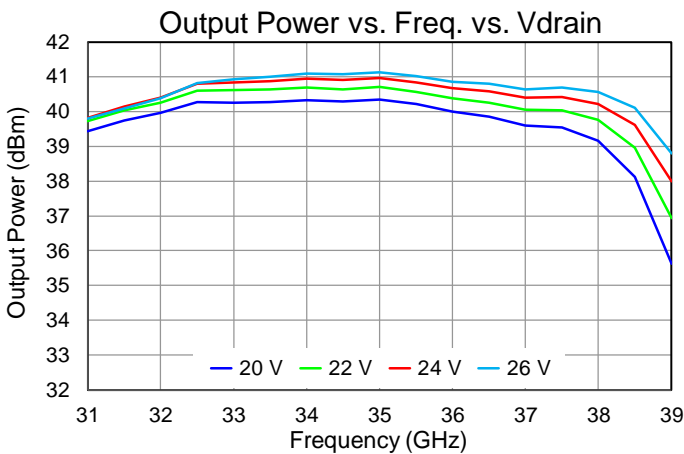
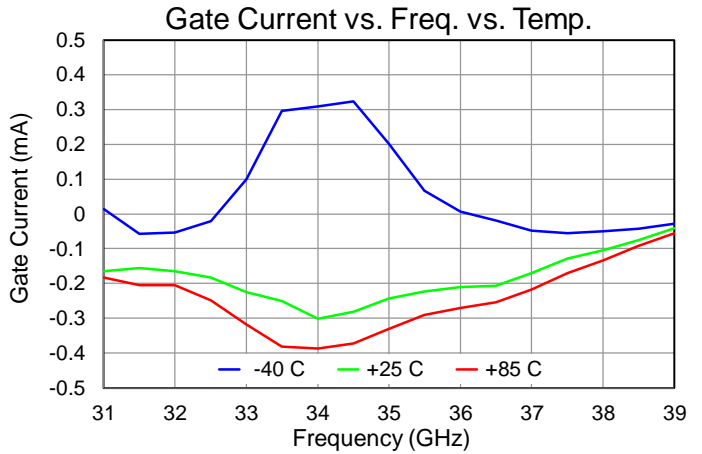
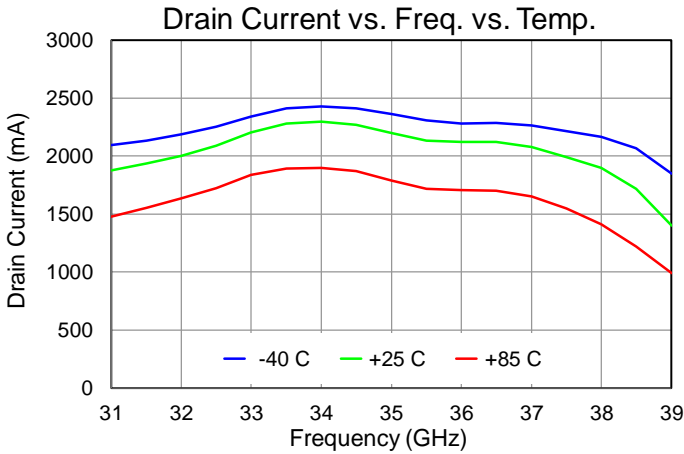
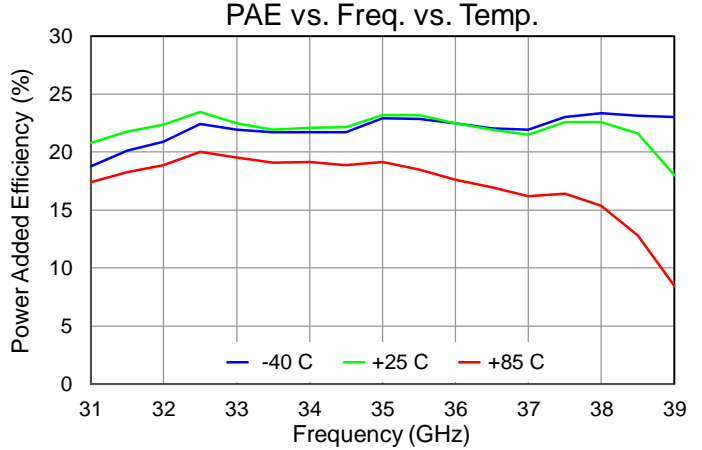
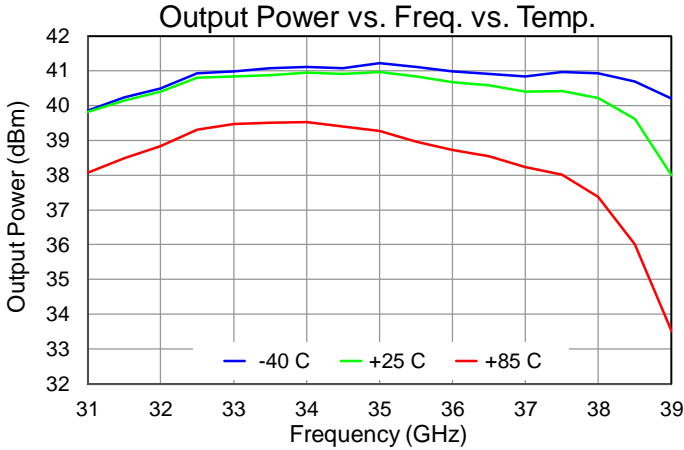
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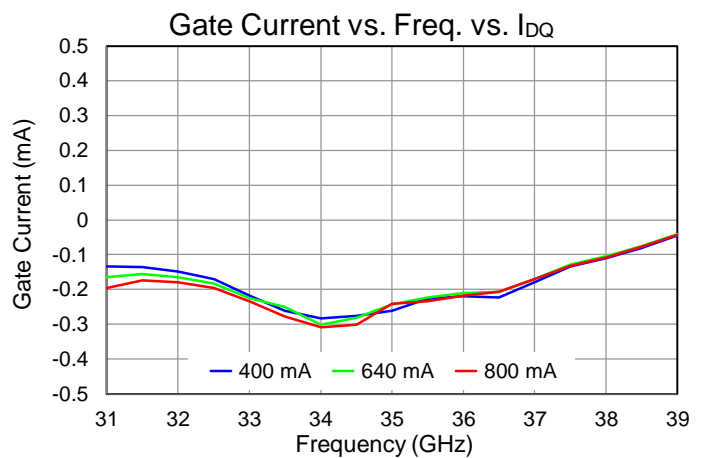
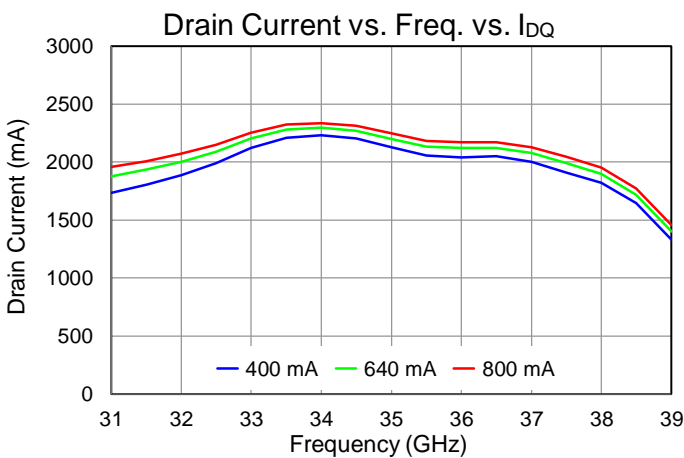
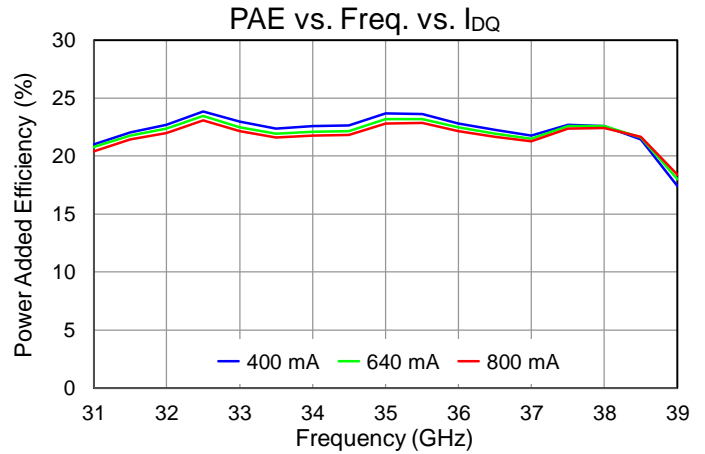
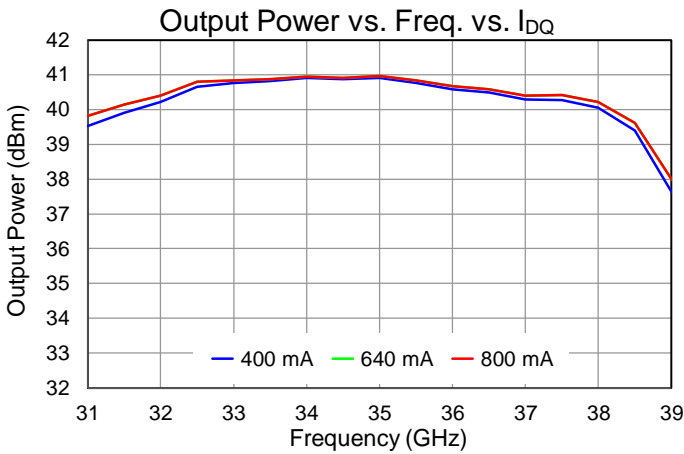
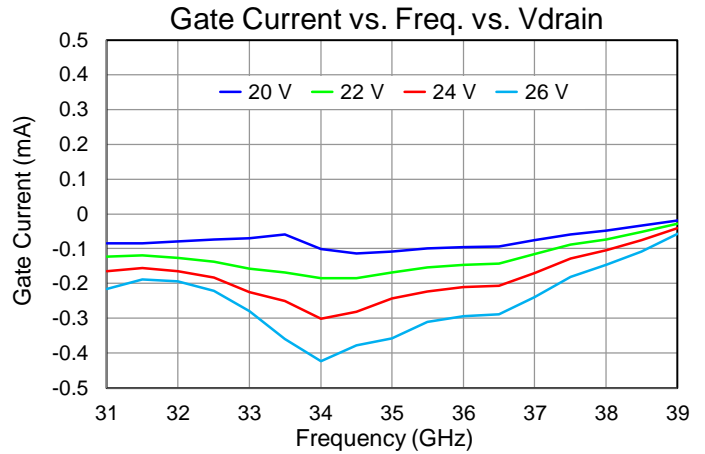
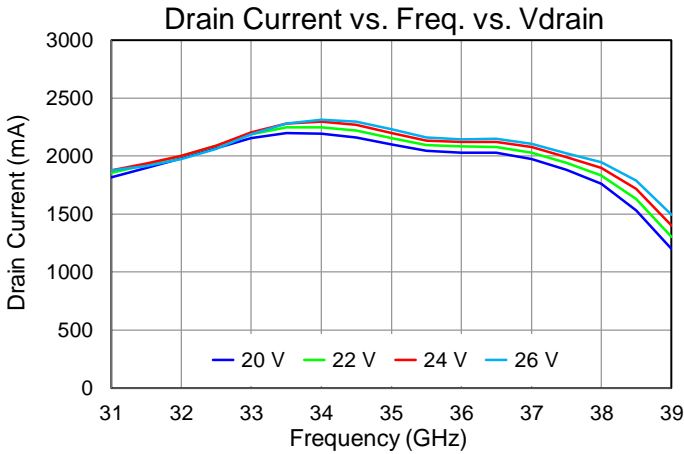
## Performance Plots – Large Signal (CW)

Test conditions, unless otherwise noted:  $V_D=24\text{ V}$ ,  $I_{DQ}=640\text{ mA}$ ,  $T=+25\text{ }^\circ\text{C}$ ,  $P_{IN}=24\text{ dBm}$



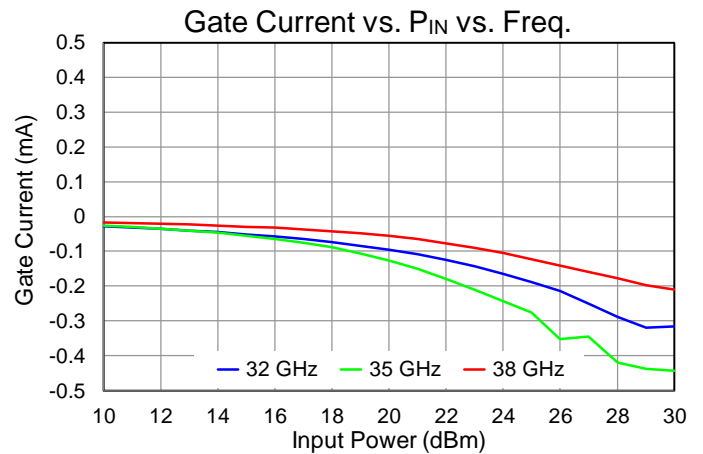
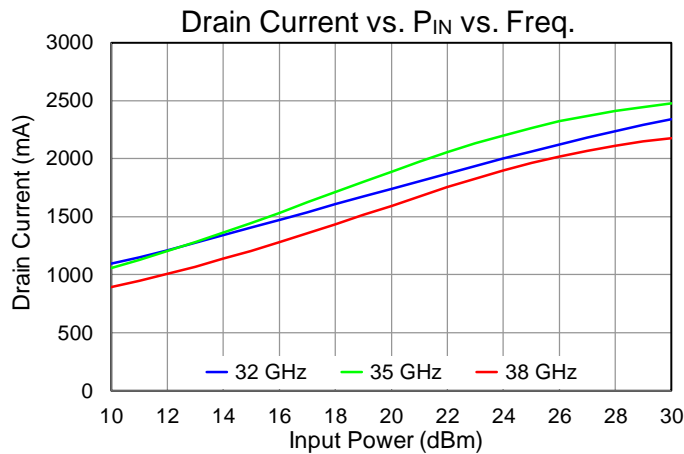
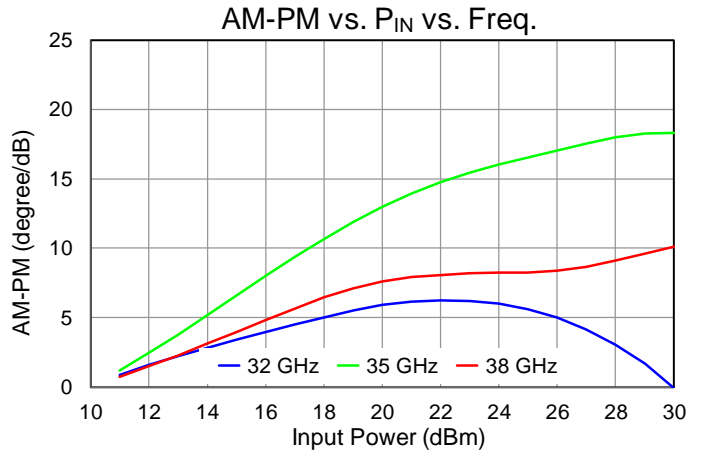
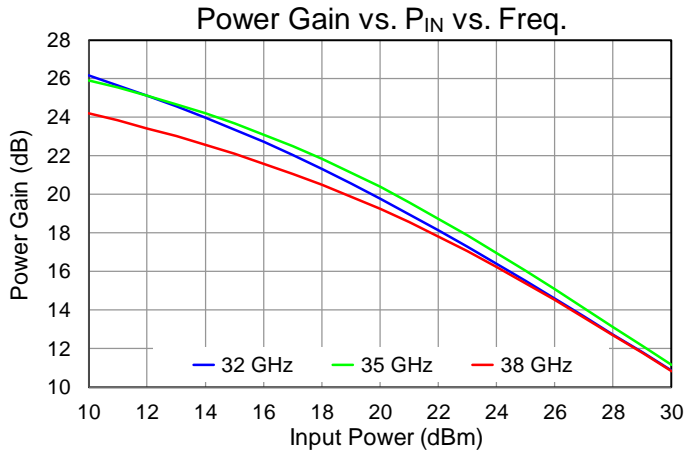
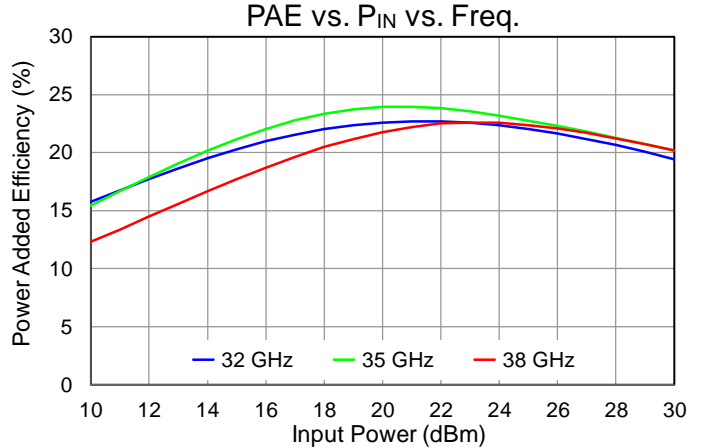
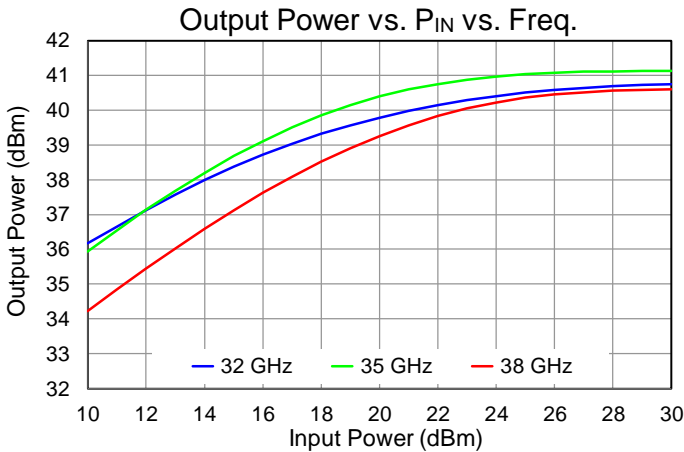
## Performance Plots – Large Signal (CW)

Test conditions, unless otherwise noted:  $V_D=24\text{ V}$ ,  $I_{DQ}=640\text{ mA}$ ,  $T=+25\text{ }^\circ\text{C}$ ,  $P_{IN}=24\text{ dBm}$



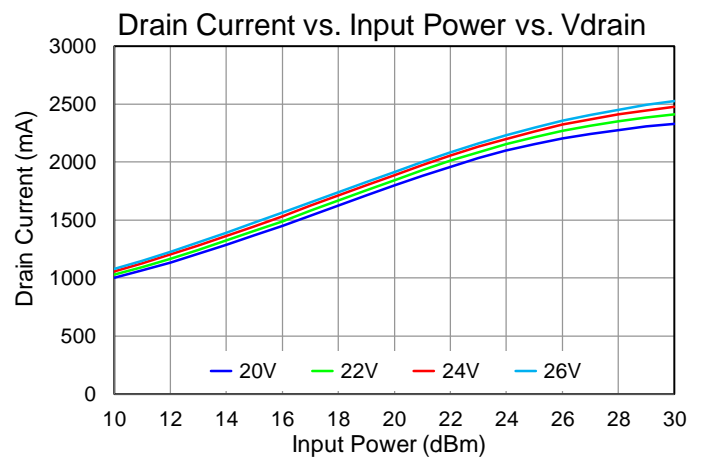
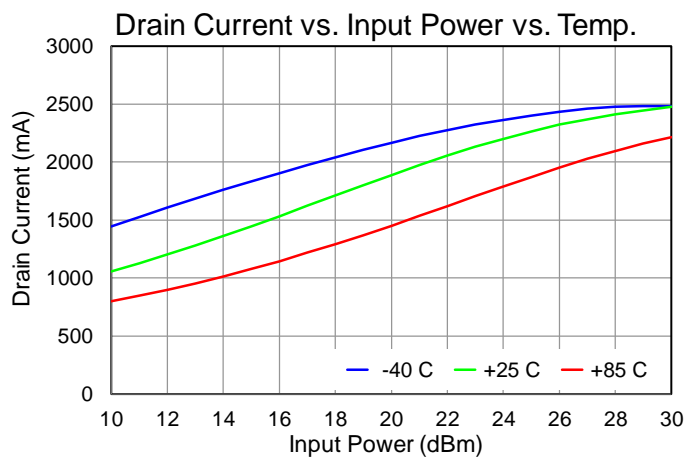
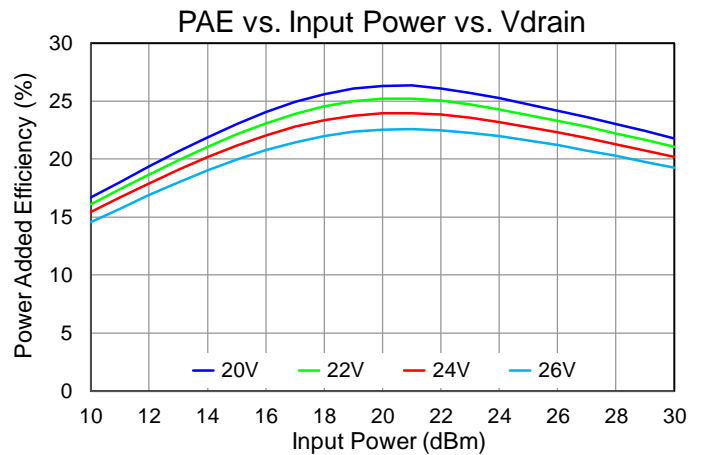
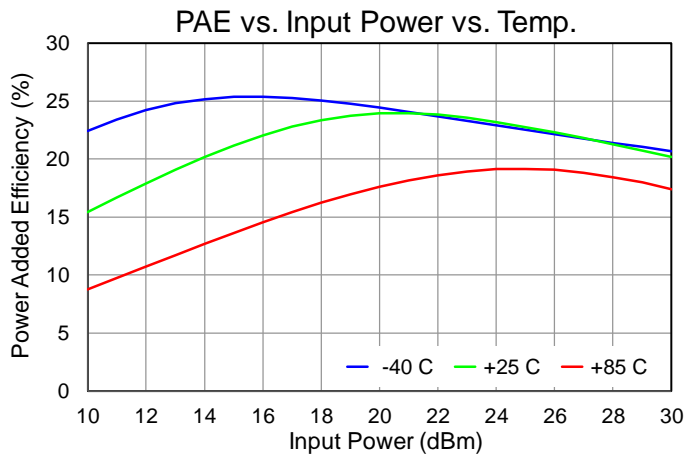
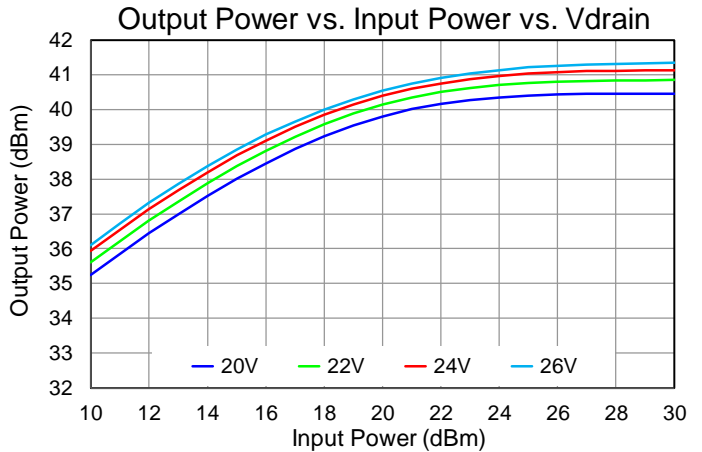
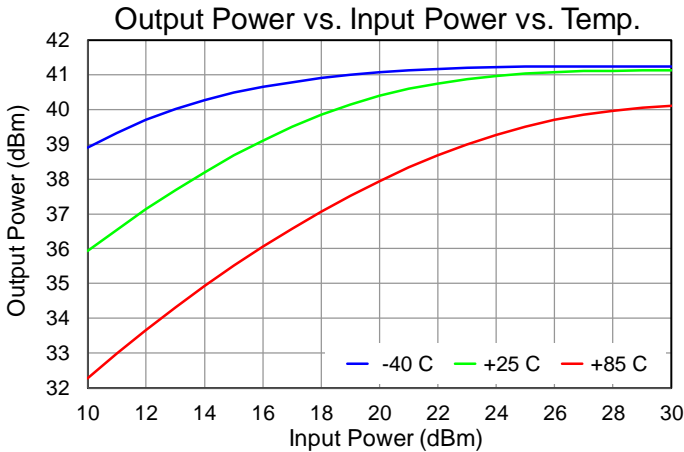
## Performance Plots – Large Signal (CW)

Test conditions, unless otherwise noted:  $V_D=24\text{ V}$ ,  $I_{DQ}=640\text{ mA}$ ,  $T=+25\text{ }^\circ\text{C}$



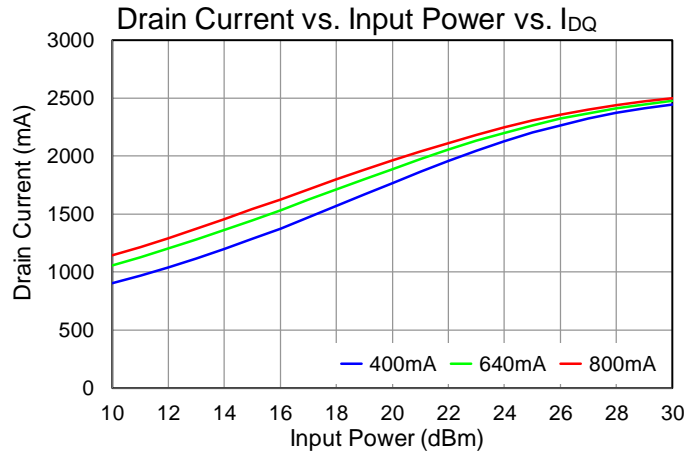
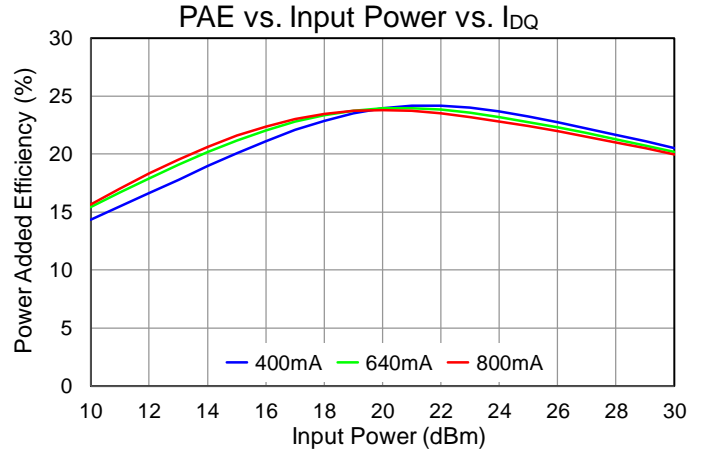
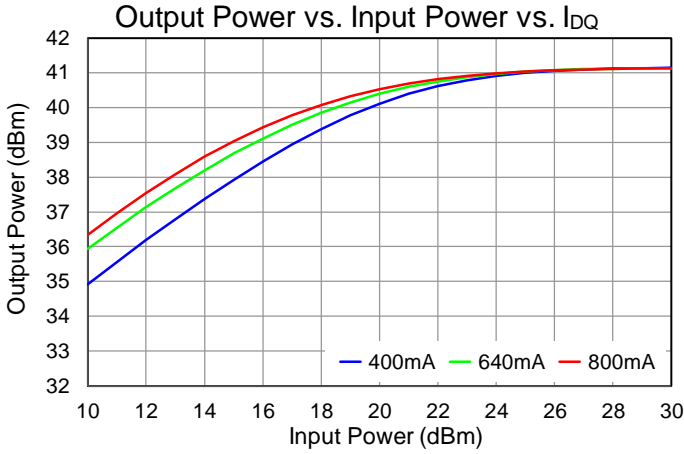
## Performance Plots – Large Signal (CW)

Test conditions, unless otherwise noted:  $V_D=24\text{ V}$ ,  $I_{DQ}=640\text{ mA}$ ,  $T=+25\text{ }^\circ\text{C}$ , Freq. = 35 GHz



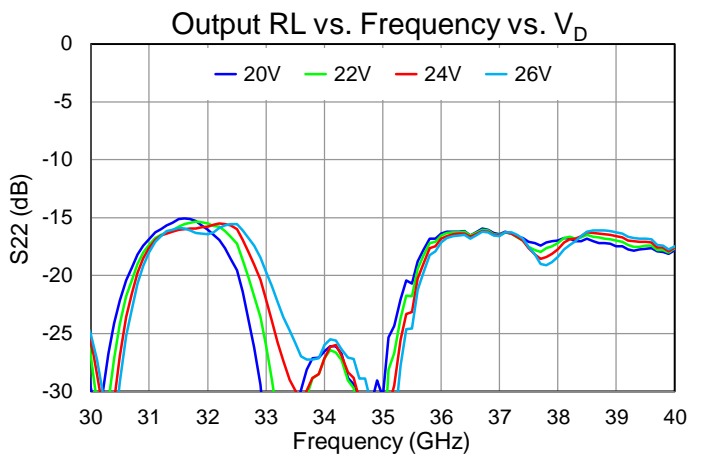
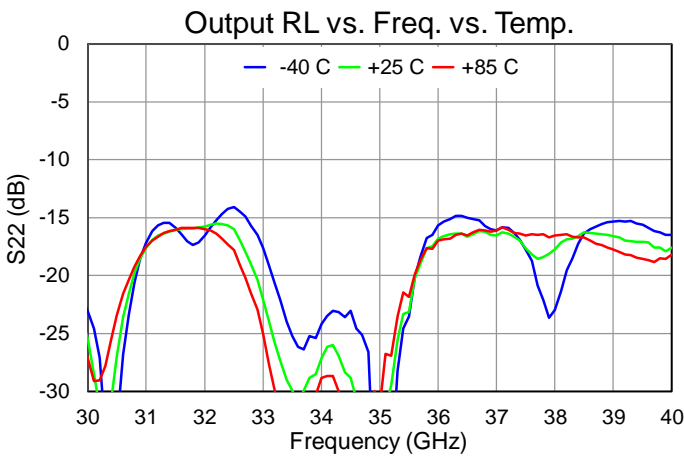
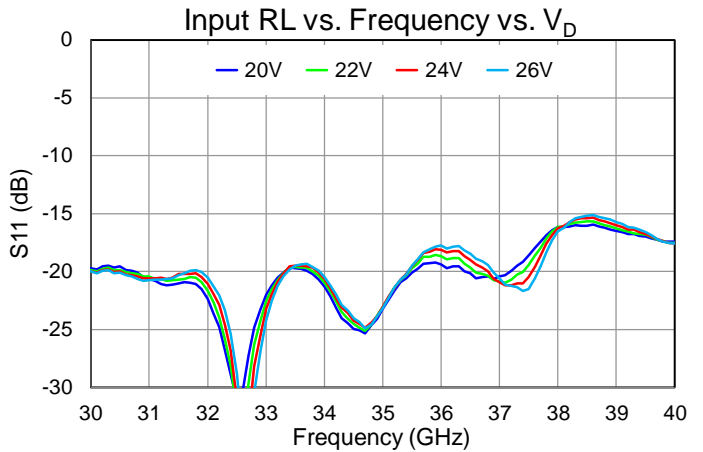
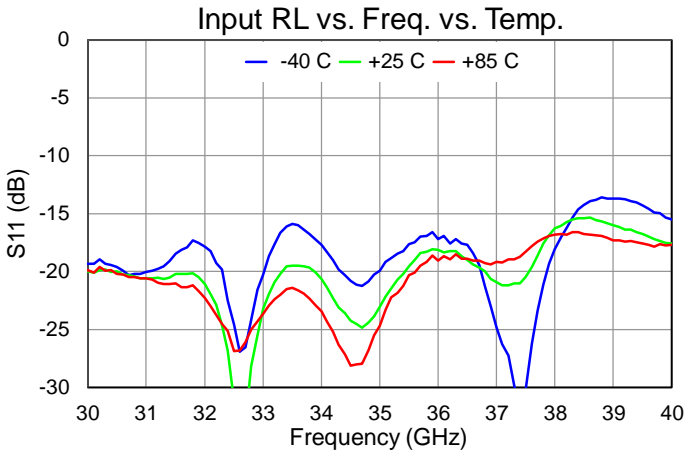
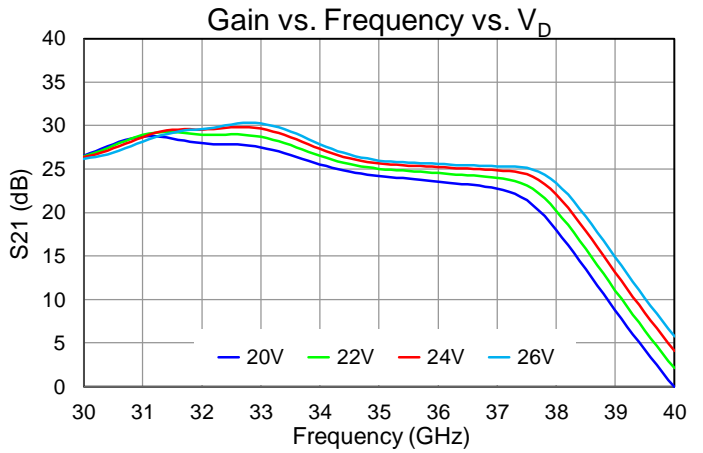
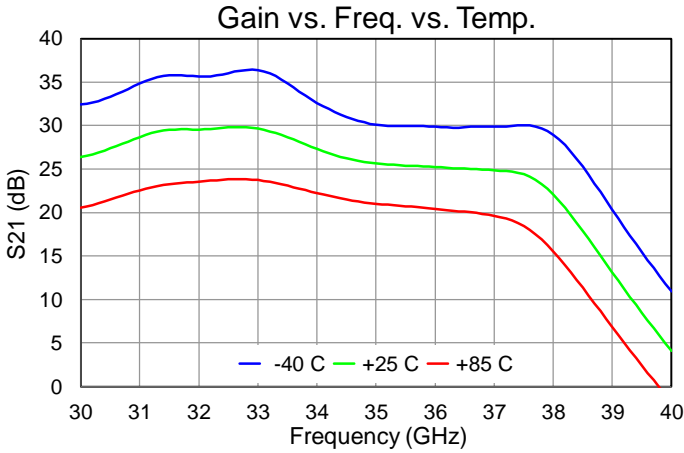
## Performance Plots – Large Signal (CW)

Test conditions, unless otherwise noted:  $V_D=24\text{ V}$ ,  $I_{DQ}=640\text{ mA}$ ,  $T=+25\text{ }^\circ\text{C}$ , Freq. = 35 GHz



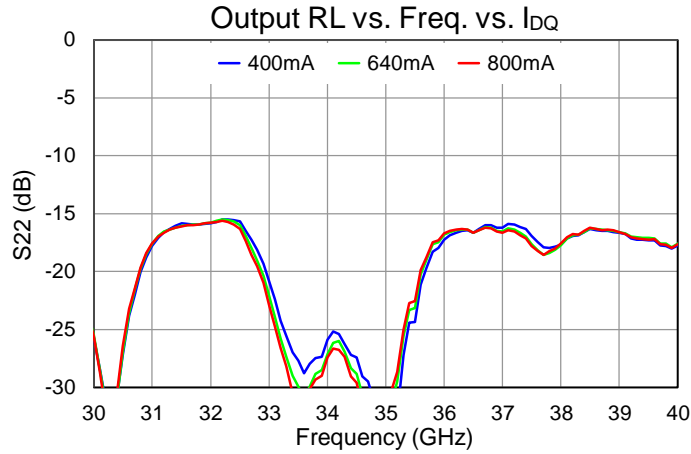
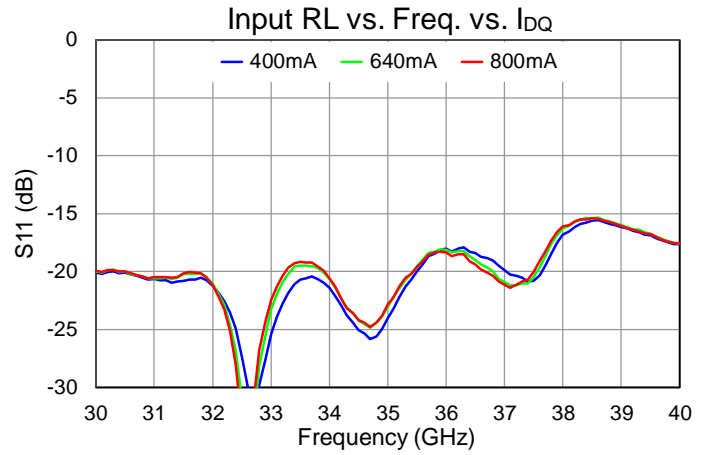
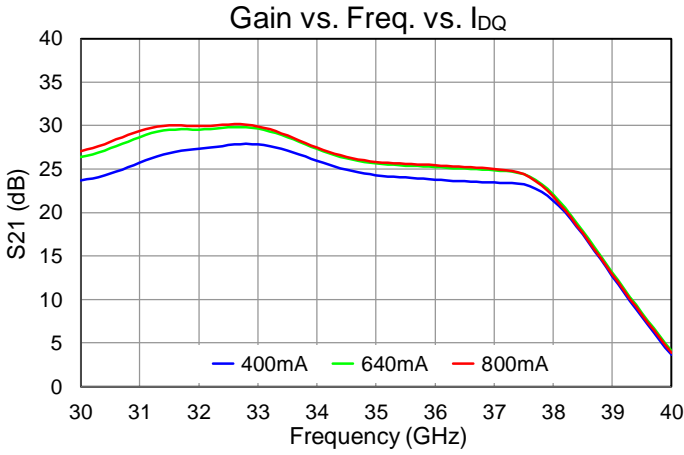
Performance Plots – Small Signal

Test conditions, unless otherwise noted:  $V_D=24\text{ V}$ ,  $I_{DQ}=640\text{ mA}$ ,  $T=+25\text{ }^\circ\text{C}$



## Performance Plots – Small Signal

Test conditions, unless otherwise noted:  $V_D=24\text{ V}$ ,  $I_{DQ}=640\text{ mA}$ ,  $T=+25\text{ }^\circ\text{C}$



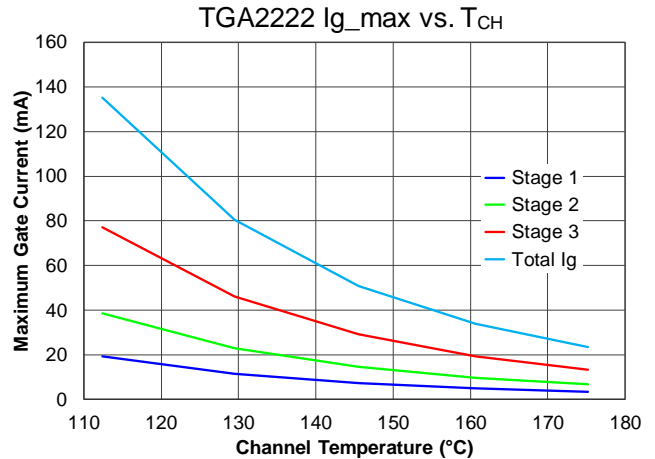
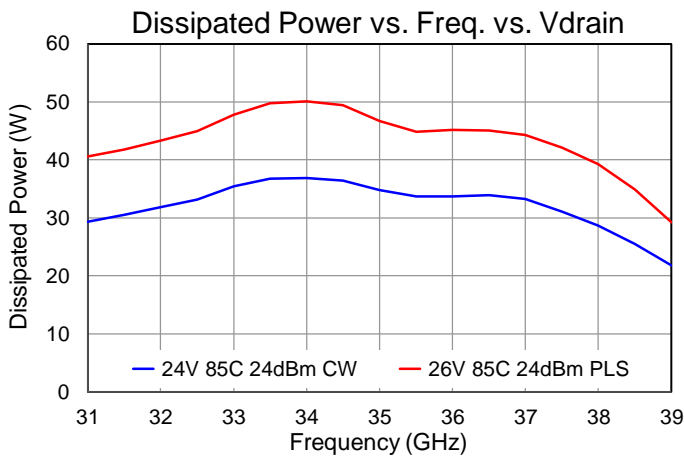
## Thermal and Reliability Information

Parameter	Test Conditions	Value	Units
Thermal Resistance ( $\theta_{JC}$ ) <sup>(1)</sup>	T <sub>base</sub> = 85 °C, V <sub>D</sub> = 26 V, I <sub>DQ</sub> = 640 mA, P <sub>DISS</sub> = 16.64 W, No RF (quiescent DC operation)	2.584	°C/W
Channel Temperature, T <sub>CH</sub> <sup>(2)</sup>		128	°C
Thermal Resistance ( $\theta_{JC}$ ) <sup>(1)</sup>	T <sub>base</sub> = 85 °C, V <sub>D</sub> = 26 V, I <sub>DQ</sub> = 640 mA, Freq = 34.0 GHz, I <sub>D_Drive</sub> = 2.374 A, P <sub>IN</sub> = 24 dBm, P <sub>OUT</sub> = 40.7 dBm, P <sub>DISS</sub> = 50.07 W (Pulsed; 100us/10%)	2.077	°C/W
Channel Temperature, T <sub>CH</sub> (Under RF) <sup>(2)</sup>		189	°C
Thermal Resistance ( $\theta_{JC}$ ) <sup>(1)</sup>	T <sub>base</sub> = 85 °C, V <sub>D</sub> = 24 V, I <sub>DQ</sub> = 640 mA, Freq = 34.0 GHz, I <sub>D_Drive</sub> = 1.899 A, P <sub>IN</sub> = 24 dBm, P <sub>OUT</sub> = 39.5 dBm, P <sub>DISS</sub> = 36.86 W (CW)	2.876	°C/W
Channel Temperature, T <sub>CH</sub> (Under RF) <sup>(2)</sup>		191	°C

**Notes:**

1. Thermal resistance determined to the back of a 20 mil Cu-Mo carrier plate with eutectic die attach (85 °C)
2. Refer to the following document: [GaN Device Channel Temperature, Thermal Resistance, and Reliability Estimates](#)

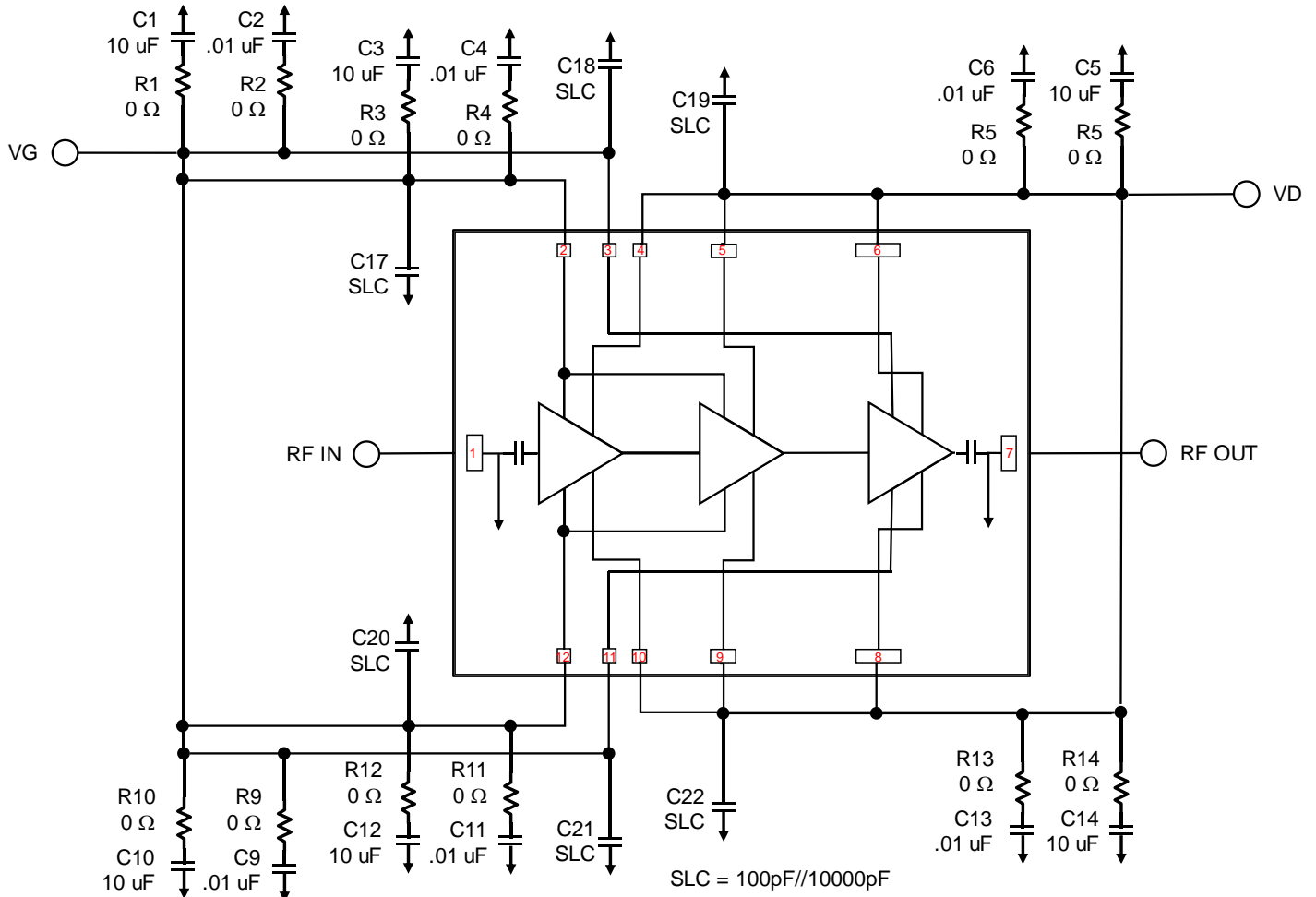
## Dissipated Power and Maximum Gate Current



Test conditions, unless otherwise noted: I<sub>DQ</sub> = 640 mA, T = +85 °C, Pin = 24 dBm



Applications Information



Note:  $V_G$  and  $V_D$  must be biased from both sides.  
Remove C5 and C14 for pulsed operation.

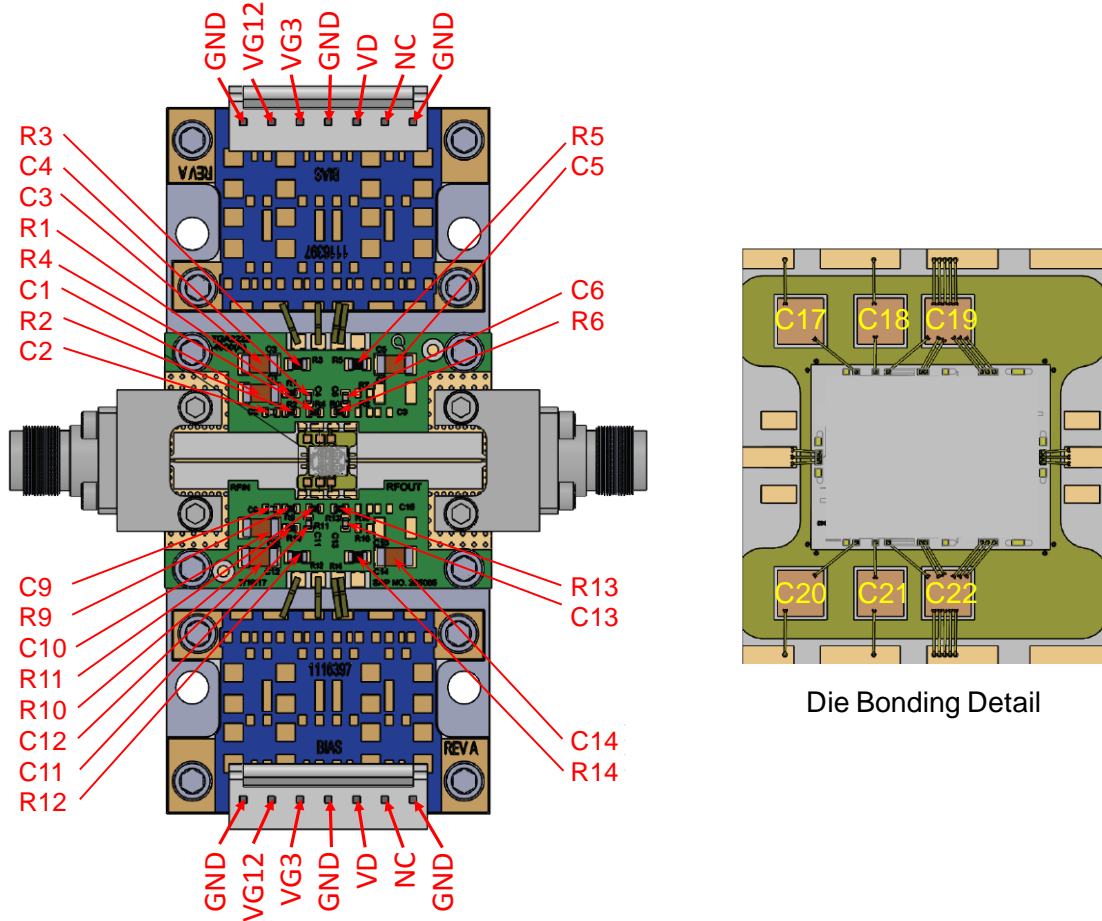
Bias-Up Procedure

1. Set  $I_D$  limit to 2700 mA,  $I_G$  limit to 5 mA
2. Set  $V_G$  to -4.0 V
3. Set  $V_D$  +26 V (pulsed) or +24 V (CW)
4. Adjust  $V_G$  more positive until  $I_{DQ} \approx 640$  mA
5. Apply RF signal

Bias-Down Procedure

1. Turn off RF signal
2. Reduce  $V_G$  to -4.0 V. Ensure  $I_{DQ} \sim 0$  mA
4. Set  $V_D$  to 0 V
5. Turn off  $V_D$  supply
6. Turn off  $V_G$  supply

Evaluation Board (EVB) Layout Assembly

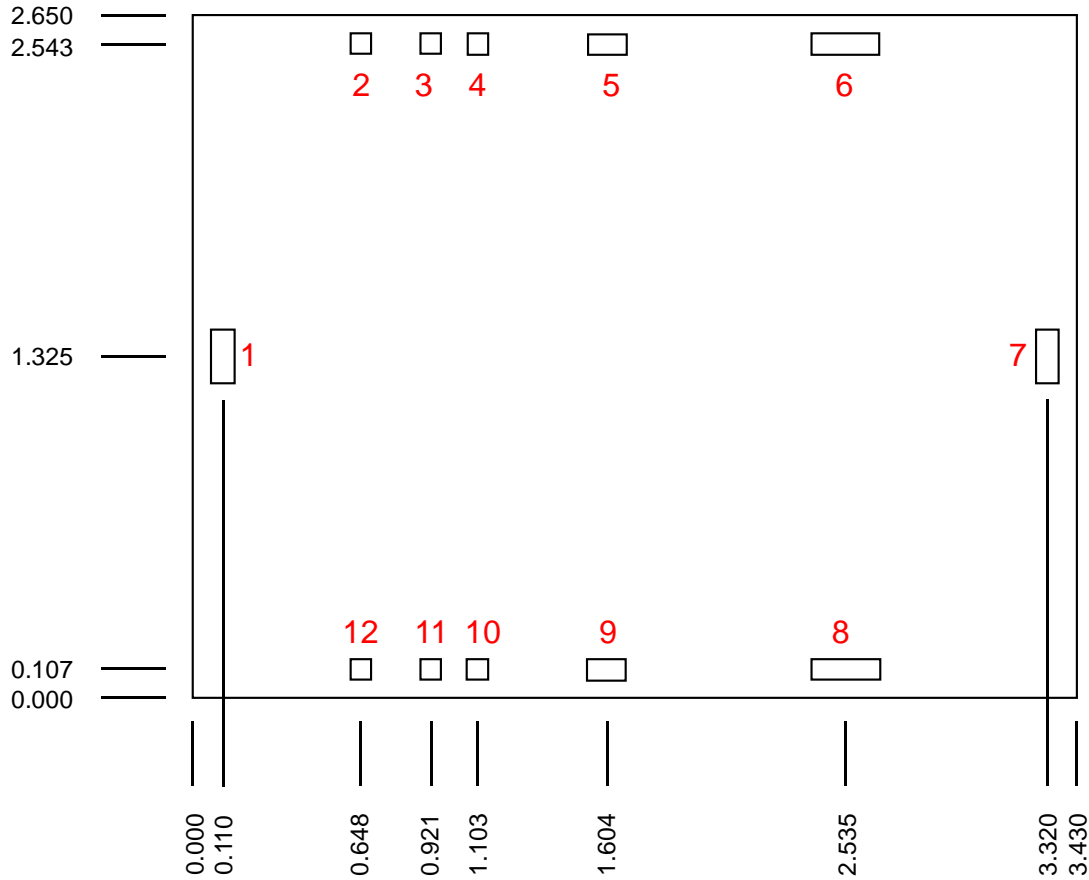


PCB is made from Rogers RO6202 dielectric, .005 inch thick, 0.5 oz. copper both sides.

Bill of Materials

Reference Des.	Value	Description	Manuf.	Part Number
C1,C3,C5,C10,C12,C14	10 uF	CAP, 10uF, 20%, 50V, 20%, X5R, 1206	Various	
C2,C4,C6,C9,C11,C13	0.01 uF	CAP, 0.01uF, 10%, 50V, X7R, 0402	Various	
C17,C18,C19,C20,C21,C22	10K//100pF	CAP, 10K//100pF, ±20%, 50V, X7R, 30X30,SL	Presidio Components	MVB3030X103M2H5C1F
R1,R2,R4,R6,R9,R10,R11,R13	0 Ω	RES, 0 OHM, JMPR, 0402	Various	
R3,R5,R12,R14	0 Ω	RES, 0 OHM, 1/10 W, 0603	Various	
J1, J2	2.4 mm	CONNECTOR, FEMALE, ENDLAUNCH	Southwest Microwave	1492-04A-5

Mechanical Information



Dimensions are in mm  
Thickness: 0.050  
Die x, y size tolerance: ± 0.050  
Ground is backside of die

Bond Pad Description

Pad No.	Symbol	Description
1	RF IN	RF input. 50 Ohms. DC shorted to ground.
2, 12	VG12	Gate voltage, stages 1 and 2. Bypass network required; refer to page 16.
3, 11	VG3	Gate voltage, stage 3. Bypass network required; refer to page 16.
4, 10	VD1	Drain voltage, stage 1. Bypass network required; refer to page 16.
5, 9	VD2	Drain voltage, stage 2. Bypass network required; refer to page 16.
6, 8	VD3	Drain voltage, stage 3. Bypass network required; refer to page 16.
7	RF OUT	RF output. 50 Ohms. DC shorted to ground.

## Assembly Notes

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Component placement and adhesive attachment assembly notes:

- Vacuum pencils and/or vacuum collets are the preferred method of pick up.
- Air bridges must be avoided during placement.
- The force impact is critical during auto placement.


Reflow process assembly notes:

- Use AuSn (80/20) solder and limit exposure to temperatures above 300 °C for 30 seconds, maximum.
- An alloy station or conveyor furnace with reducing atmosphere should be used.
- Do not use any kind of flux.
- Coefficient of thermal expansion matching is critical for long-term reliability.
- Devices must be stored in a dry nitrogen atmosphere.

Interconnect process assembly notes:

- Thermosonic ball bonding is the preferred interconnect technique.
- Force, time, and ultrasonic are critical parameters.
- Aluminum wire should not be used.
- Devices with small pad sizes should be bonded with 0.0007-inch wire.

## Handling Precautions

Parameter	Rating	Standard	 Caution! ESD-Sensitive Device
ESD – Human Body Model (HBM)	1A	ANSI/ESD/JEDEC JS-001	

## Solderability

Use only AuSn (80/20) solder, and limit exposure to temperatures above 300 °C to 30 seconds, maximum.

## RoHS Compliance

This part is compliant with 2011/65/EU RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment) as amended by Directive 2015/863/EU.

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A (C<sub>15</sub>H<sub>12</sub>Br<sub>4</sub>O<sub>2</sub>) Free
- PFOS Free
- SVHC Free

## Contact Information

For the latest specifications, additional product information, worldwide sales and distribution locations:

Web: [www.qorvo.com](http://www.qorvo.com)

Tel: 1-844-890-8163

Email: [customer.support@qorvo.com](mailto:customer.support@qorvo.com)

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